

<b>Notice of References Cited</b>	Application/Control No. 10/708,940		Applicant(s)/Patent Under Reexamination BANDE ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0103215	05-2004	Ernst et al.	709/247
*	B	US-6,832,241	12-2004	Tracton et al.	709/203
*	C	US-5,276,898	01-1994	Kiel et al.	718/105
*	D	US-2005/0144309	06-2005	Gish, David W.	709/233
*	E	US-2003/0123466	07-2003	Somekh et al.	370/401
*	F	US-2004/0205249	10-2004	Berry, Wayne	709/247
*	G	US-2005/0210151	09-2005	Abdo et al.	709/247
*	H	US-2005/0268068	12-2005	Ignatius et al.	711/202
*	I	US-2002/0184224	12-2002	Haff et al.	707/10
*	J	US-7,043,524	05-2006	Shah et al.	709/203
*	K	US-7,024,460	04-2006	Koopmas et al.	709/206
*	L	US-6,535,238	03-2003	Kressin, Mark Scott	348/14.01
*	M	US-2005/0188112	08-2005	Desai et al.	709/247

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/097584	12-2002	USA	Cranstone et al.	G06F
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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